

# Characteristics of Final Particles in Multiple Compton Backscattering Process

A. Potylitsyn

Tomsk Polytechnic University,  
Tomsk, Russia



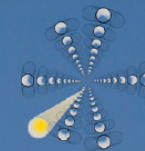
5<sup>th</sup> International Conference



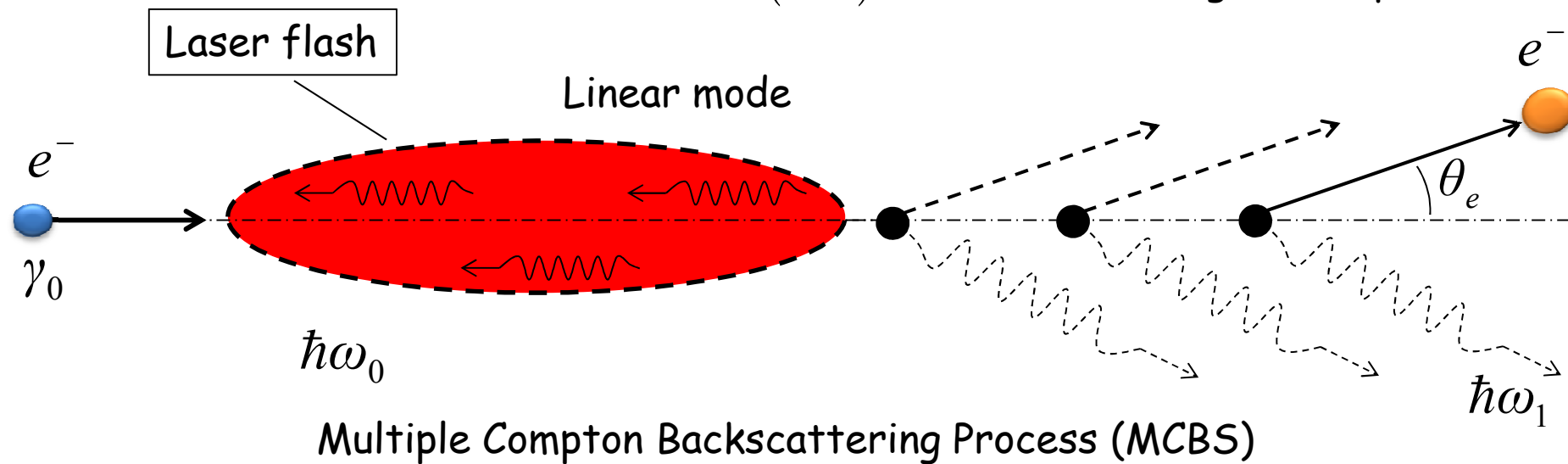
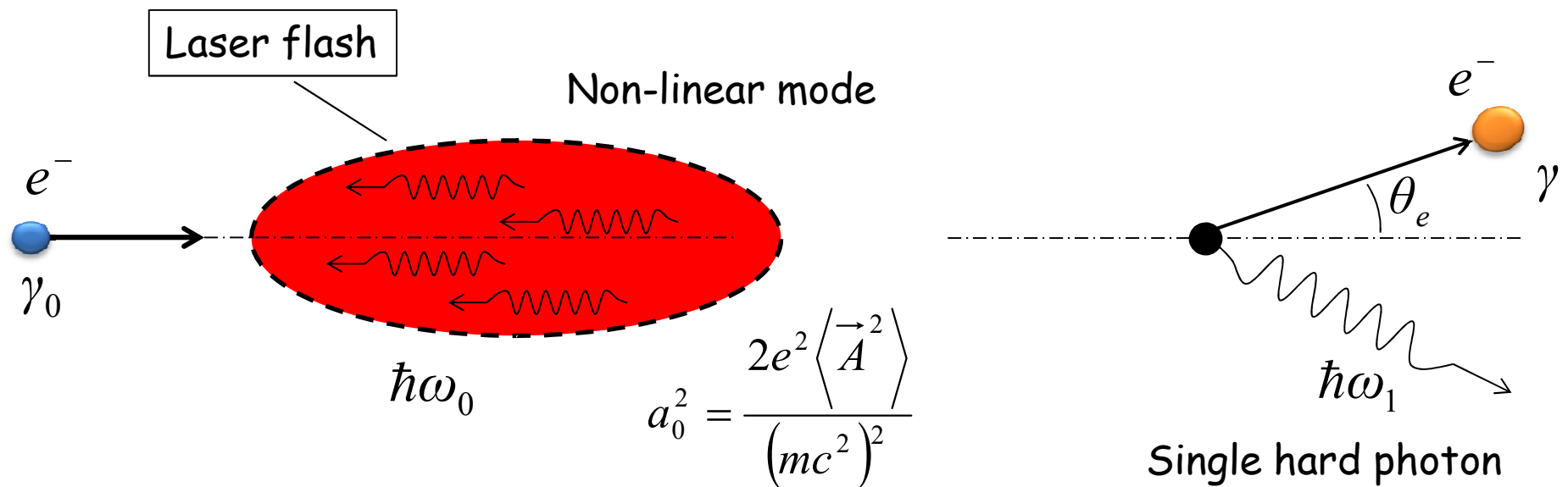
**Charged & Neutral Particles Channeling Phenomena**

September 23-28, 2012 Alghero, Italy  
Hotel Calabona

**Channeling 2012**



# Compton backscattering

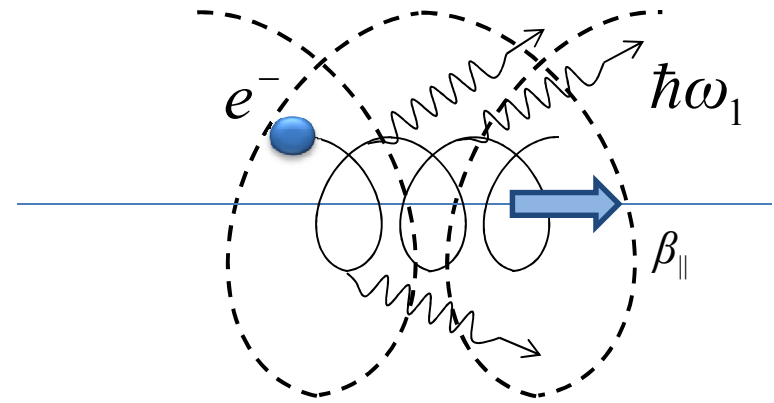
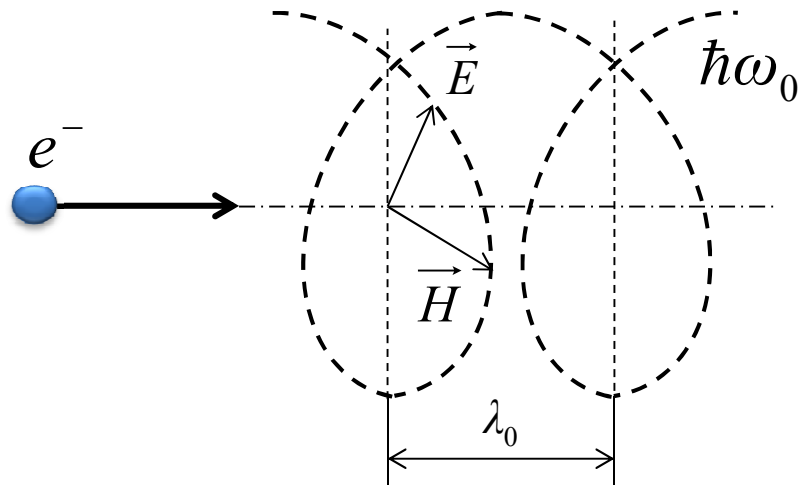


$$a_0^2 \ll 1$$

$$\theta_e \sim \frac{\hbar\omega_0}{mc^2} \leq 10^5$$

# Plane - wave approximation

## Circularly-polarized wave

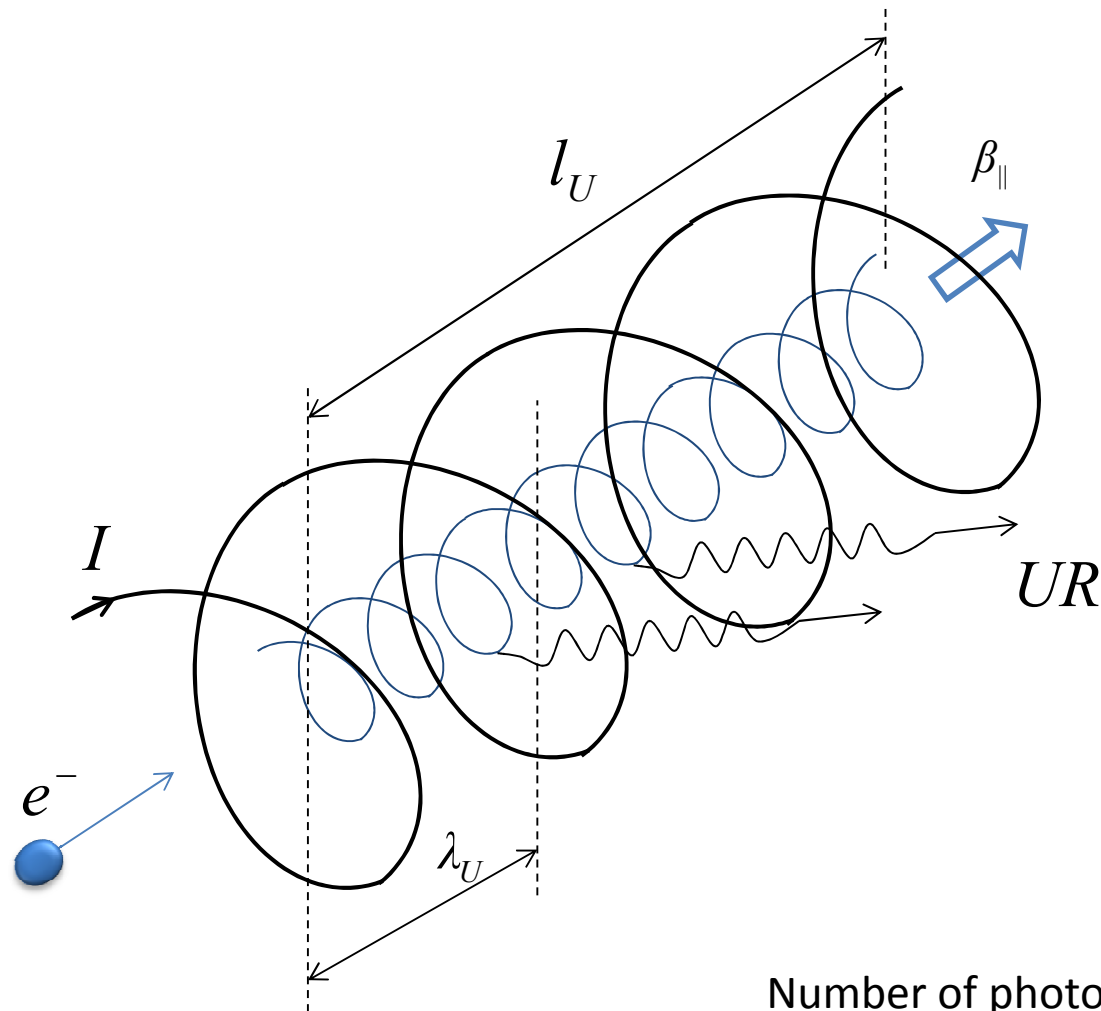


Radius of electron trajectory

$$r_{\perp} \sim a_0 \lambda_0$$

MCBS may be treated as undulator radiation in a field of intense plane wave ("light undulator")

# Undulator radiation



$$K = \frac{eH\lambda_U}{2\pi mc^2}$$

Number of photons per electron in undulator

$$\bar{k}_{UR} = Rl_U,$$

Rate of emitted photons  $R = \frac{2}{3} \pi \alpha K^2 \frac{1}{\lambda_U}, (K^2 \ll 1)$

$\bar{k}_{UR}$  Is a random value

## MCBS process ("light undulator")

$$K^2 \rightarrow a_0^2, \quad \lambda_U \rightarrow \frac{\lambda_0}{2}$$

$$\bar{k}_{MCBS} = \frac{2}{3} \pi \alpha a_0^2 l_L, \quad l_L \text{ — length of a laser pulse, } l_L = N_0 \lambda_0$$

$$a_0^2 = 4\pi\alpha \hat{\lambda}_e^2 \lambda_0 n_0,$$

$$\hat{\lambda}_e = \frac{\hbar}{mc}, \quad n_0 \text{ — mean concentration of laser photons.}$$

$$\bar{k}_{MCBS} = 2 \cdot \frac{8\pi}{3} r_e^2 n_0 l_L = 2\sigma_T n_0 l_L$$

where  $\sigma_T = \frac{8\pi}{3} r_e^2$  — Thomson cross-section

The strict number of MCBS photons is defined from luminosity

$$L = c(1 + \beta_0) \sigma N_e N_L \int dV dt F_e(x, z, y, t) F_L(x, y, z, t)$$

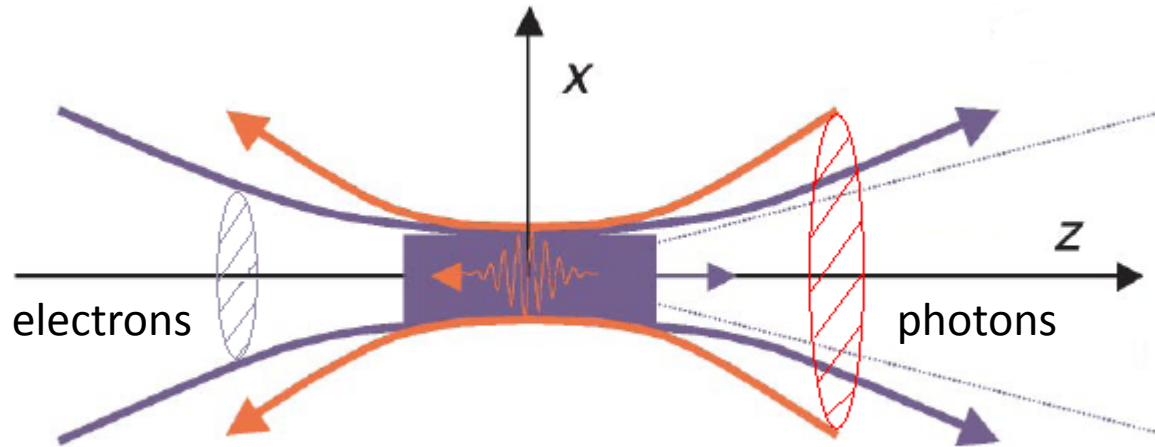
$N_{e(L)}$  — number of electrons (photons) in bunches

$F_{e(L)}(x, y, z, t)$  — distribution of each bunches in the space and time

Mean number of emitted photons (number of collisions) per electron

$$\bar{k}_{MCBS} = L / N_e$$

## Mean collision number per each initial electron. (number of photons per particle)



$$f_L \sim \exp\left(-\frac{\rho^2}{\rho_L^2}\right),$$

$$f_e \sim \exp\left(-\frac{\rho^2}{\rho_e^2}\right)$$

**F. Hartemann et al. PRST – AB, (2005)1007 02**      $\rho_L^2 = \rho_0^2 \left(1 + \frac{z^2}{z_R^2}\right), \quad \rho_e^2 = \rho_b^2 \left(1 + \frac{z^2}{\beta_f^2}\right).$

$\rho_0$  ( $\rho_b$ ) is the minimum radius of photon (electron) beam.  $z_R$  is the Rayleigh length,  $\beta_f$  is the beta function.

Longitudinal distributions of beams were approximated by Gaussians with parameters  $l_L$  and  $l_e$ .

In this model the mean number of scattered photons is determined by the following expression :

$$\bar{k} = \frac{16\sqrt{\pi}}{3} \frac{r_e^2}{\rho_0^2} N_L f(l_e, l_L, r), \text{ where}$$

$$f(l_e, l_L, r) = \exp[(1+r^2)/(\mu^2 + r^2\eta^2)] / [(\mu^2 + r^2\eta^2)(1+r^2)]^{1/2} \times \left\{1 - \Phi\left[(1+r^2)^{1/2} / (\mu^2 + r^2\eta^2)^{1/2}\right]\right\},$$

$$\mu = \frac{l_L}{2\sqrt{2}z_R}, \quad \eta = \frac{l_e}{2\sqrt{2}\beta_f}, \quad r = \frac{\rho_b}{\rho_0}, \quad \Phi(x) \text{ is the error function.}$$

Simplest case  $\rho_L = const, \rho_e = const$

In the limit  $z_R \rightarrow \infty, \beta_f \rightarrow \infty (\mu, \eta \rightarrow 0)$

$$1 - \Phi(x) \approx \frac{1}{\sqrt{\pi}} \frac{\exp(-x^2)}{x},$$

$$\bar{k} \approx \frac{16}{3} N_L \frac{r_e^2}{\rho_0^2 + \rho_e^2}$$

or using luminosity L :  $\bar{k} = \frac{L\sigma}{N_e}$

Introducing a mean photon concentration  $n_0$  and effective length  $l_L$  of a laser flash :

$$n_0 = \frac{N_L}{V_{eff}} = \frac{W_L}{\hbar\omega_0} \frac{1}{\pi\rho_{eff}^2 l_L} :$$

$$\bar{k} \approx l_L 2\sigma_T (1 - x_0) n_0 \approx \frac{l_L}{l_T} \text{ for } x_0 \ll 1, \quad x_0 \approx \frac{4\gamma_0 \hbar\omega_0}{mc^2}$$

Where  $l_T = \frac{1}{2n_0\sigma_T}$  - so - called Thomson free path electron length in a "light target".

# Scheme for production of polarized positrons

[T. Omori et al. NIMA 500(2003)232]

The mean number of collisions  $\bar{k}$  may be estimated for parameters :

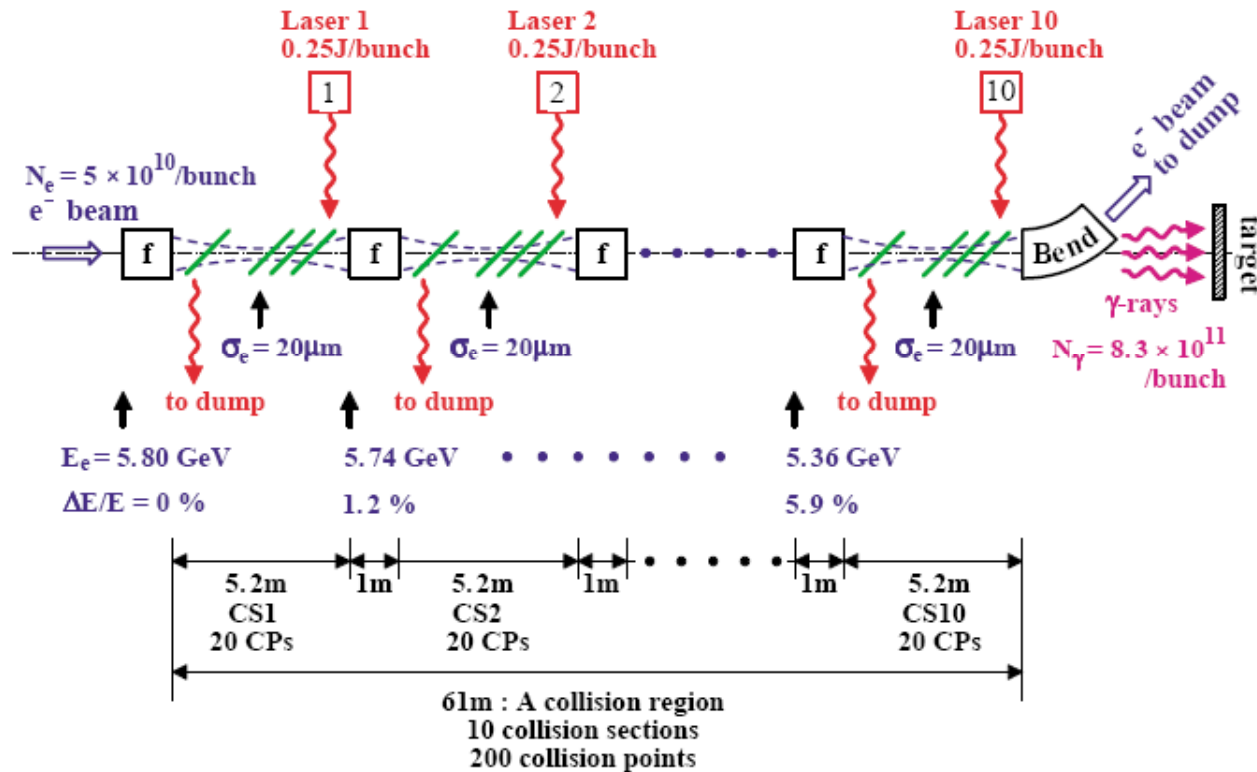
$$\begin{aligned} \rho_0 &\approx 20 \mu\text{m}, \quad z_R \approx 220 \mu\text{m}, \quad l_L \approx 3 \text{ mm} \\ \rho_b &\approx 20 \mu\text{m}, \quad \beta_f \approx 3600 \text{ mm}, \quad l_e \approx 1 \text{ mm} \\ \bar{k}_0 &\approx 0.2 \end{aligned}$$

and for 200 collision points  $\bar{k} \approx 200\bar{k}_0 \approx 40$

Due to non - gaussian laser beam authors have got the value :

$$\bar{k} = N_\gamma / N_e = 16.6$$

$$(N_\gamma = 8.3 \cdot 10^{11} \text{ photons / bunch}, \quad N_e = 5 \cdot 10^{10} e^- / \text{bunch})$$



Number of photons per electron:

$$\bar{k} = 2.4 \quad \text{CLICHE [D. Asher et al. Eur. Phys. J. C., 28 (2003) 27]}$$

$$\bar{k} = 1.2 \quad \text{SAPPHiRE [S. A. Bogacz et. al. arXiv: 1208.2827]}$$



# Analytic description of MCBS process

The cross-section of the linear MCBS process

$$\frac{d\sigma}{dy} = \frac{2\pi r_e^2}{x_0} \left[ \frac{1}{1-y} + 1-y - \frac{4y}{x_0(1-y)} \left( 1 - \frac{y}{x_0(1-y)} \right) \right],$$

$$x_0 = \frac{2p_0 k_0}{(mc^2)^2} \approx \frac{4\gamma_0 \hbar \omega_0}{mc^2}, \quad y = 1 - \frac{p_0 k}{p_0 k_0} \approx \frac{\hbar \omega}{\gamma_0 mc^2}$$

MCBS is the stochastic process where  $\bar{k}$  and electron energy losses  $\Delta\varepsilon = \varepsilon_0 - \varepsilon$

along a path  $l$  are described by the probability distribution  $P(\varepsilon, \varepsilon_0, l)$

$$\frac{\partial}{\partial l} P(\varepsilon, \varepsilon_0, l) + \Sigma(\varepsilon_0) P(\varepsilon, \varepsilon_0, l) - \int_0^{\hbar\omega_{\max}} \Sigma(\hbar\omega; \varepsilon_0) P(\varepsilon, \varepsilon_0 - \hbar\omega, l) d\hbar\omega = 0$$

with the boundary condition

$$P(\varepsilon, \varepsilon_0, l = 0) = \delta(\varepsilon - \varepsilon_0).$$

Here

$\Sigma(\hbar\omega, \varepsilon_0) = 2\bar{n}_0 \frac{d\sigma}{d\hbar\omega}$  is the differential macroscopic cross-section of the Compton scattering process and

$\Sigma(\varepsilon_0) = \int_0^{\hbar\omega_{\max}} \Sigma(\hbar\omega; \varepsilon_0) d\hbar\omega$  is the total macroscopic cross-section.

In the paper [A.Kolchuzhkin, A. Potylitsyn, S. Stokov et al., Nucl. Instr. and Meth. B 201 (2003) 307] we have derived analytical formulae for the main parameters

$$\bar{k}(\varepsilon_0, l_L) = 2\sigma_T \bar{n}_0 l_L - 2 \log \left( 1 + \frac{g_1(\varepsilon_0) l_L}{\varepsilon_0} \right),$$

$$\bar{\varepsilon}(\varepsilon_0, l_L) = \frac{\varepsilon_0}{1 + \frac{g_1(\varepsilon_0) l_L}{\varepsilon_0}},$$

$$\Delta(\varepsilon_0, l_L) = \frac{g_2(\varepsilon_0) l_L}{\left[ 1 + \frac{g_1(\varepsilon_0) l_L}{\varepsilon_0} \right]^4}.$$

where coefficients  $g_{1,2}(\varepsilon_0)$  are defined as

$$g_1(\varepsilon_0) = \int_0^{\hbar\omega_{\max}} \hbar\omega \Sigma(\hbar\omega; \varepsilon_0) d\hbar\omega,$$

$$g_2(\varepsilon_0) = \int_0^{\hbar\omega_{\max}} (\hbar\omega)^2 \Sigma(\hbar\omega; \varepsilon_0) d\hbar\omega.$$

In the case  $x_0 \ll 1$

$$\bar{\varepsilon}(\varepsilon_0, l_L) \approx \frac{\varepsilon_0}{1 + \frac{1}{2} \bar{k} x_0 \left( 1 - \frac{21}{10} x_0 \right)},$$

$$\Delta(\varepsilon_0, l_L) \approx \frac{\frac{7}{20} \bar{k} \varepsilon_0^2 x_0^2}{\left( 1 + \frac{1}{2} \bar{k} x_0 \right)^4}.$$

Or, substituting  $n_0$  and  $\hbar\omega_{max}$  instead  $\bar{k}$

$$\bar{\varepsilon} = \varepsilon_0(1 - x_0\sigma_T n_0 l_L) = \varepsilon_0 - \sigma_T n_0 \hbar\omega_{max} l_L,$$

$$\Delta^2 = \frac{7}{20} 2\sigma_T n_0 l_L \varepsilon_0^2 x_0^2 = \frac{7}{10} \sigma_T n_0 (\hbar\omega_{max})^2 l_L.$$

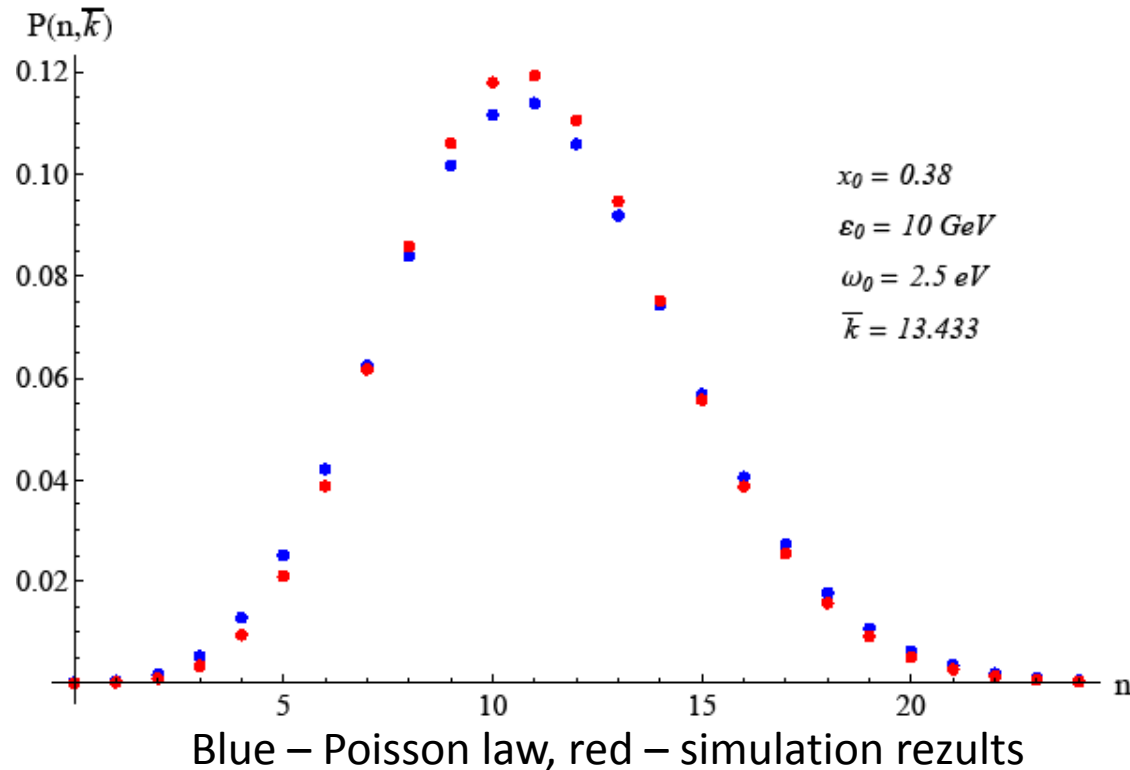
it is possible to compare expressions obtained with results:

[Robb G.R.M., Bonifacio R., *Europhys. Lett.*, 94 (2011) 34002].

The difference is  $7/10$  instead 1 in the second expression.

# Monte - Carlo simulation

Distribution over the collision number  $k$  (number of emitted photons)



$\sigma_k^2(l) = \bar{k}(l)$  - main characteristics of the Poisson law

$$P(n, \bar{k}) = \frac{\bar{k}^n \exp(-\bar{k})}{n!}$$

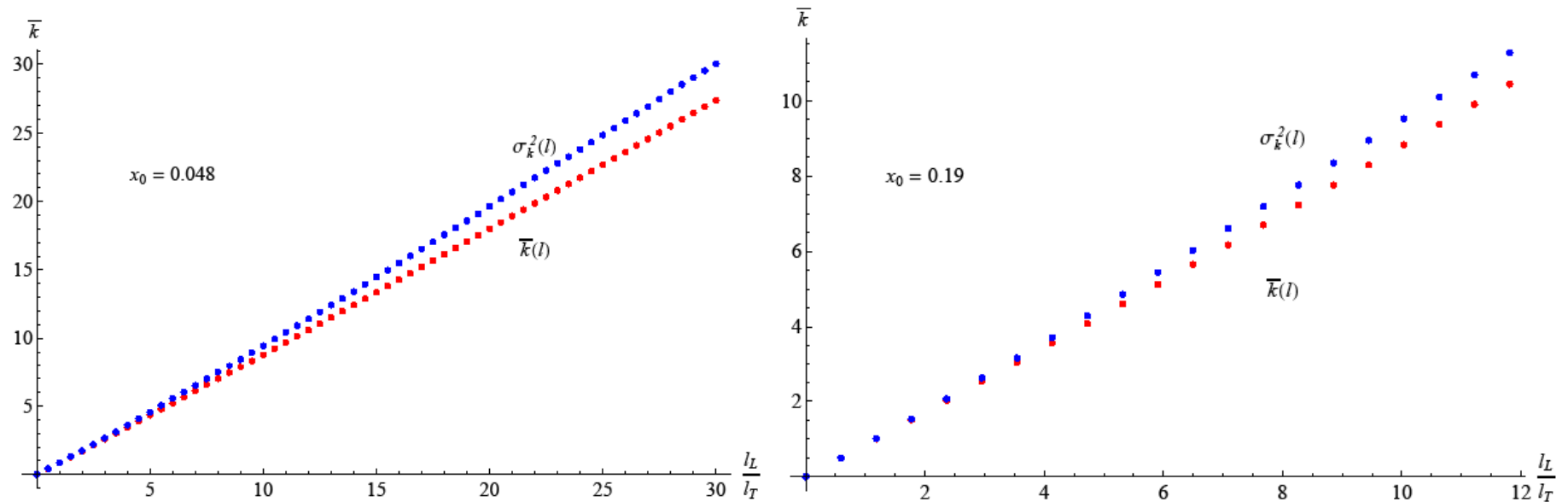
For any value of  $\bar{k}$  there is a part of electrons passing through a light target without interaction ( $n = 0$ ):

$$P(0, \bar{k}) = \exp(-\bar{k})$$

For  $\bar{k} = 1$ ,  $\exp(-\bar{k}) = 0.37 = 37\%$

A random path length and a random energy loss were successively simulated in each collision

### Comparison of $\bar{k}$ and $\sigma_k^2$

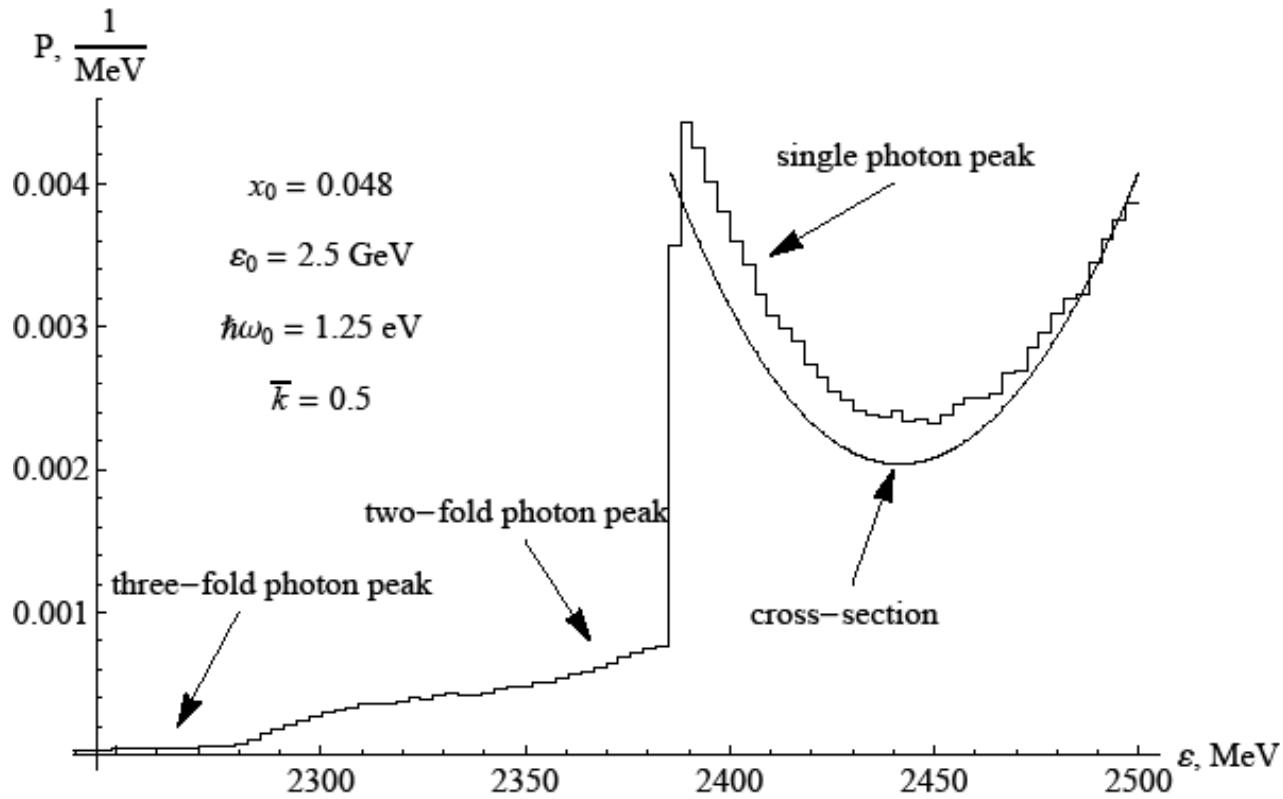


Dependencies  $\bar{k}$  and  $\sigma_k^2$  on a light target thickness.

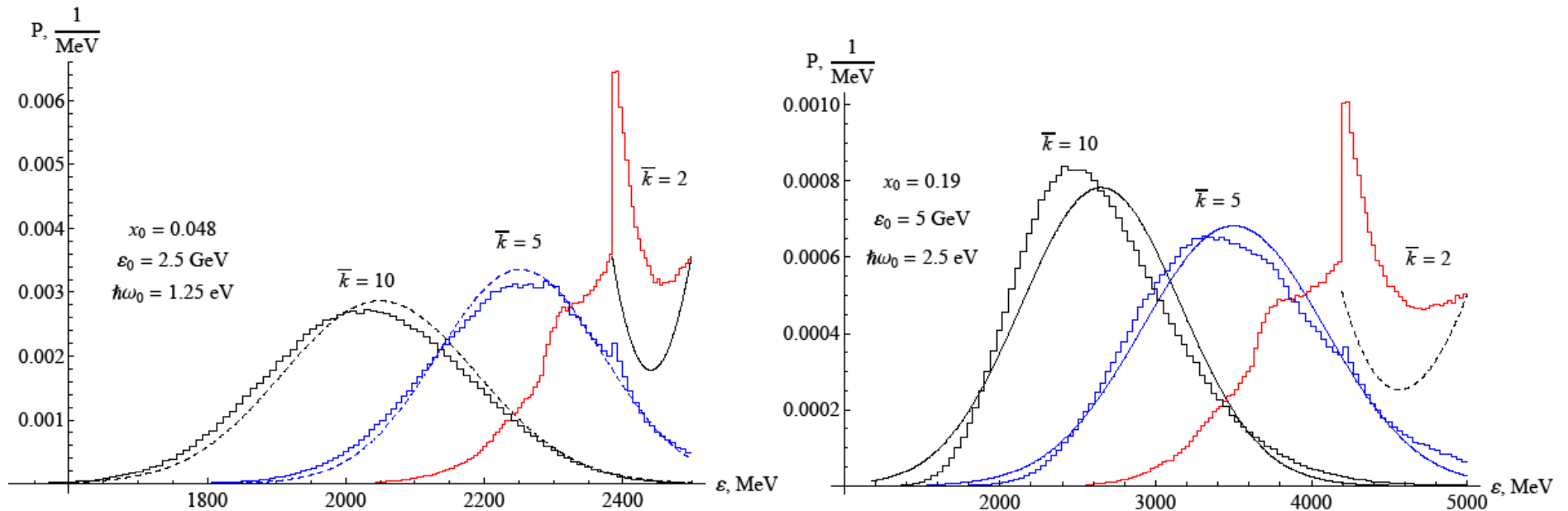
$\bar{k} = \sigma_k^2$  for small  $x_0$  and small thickness - typical characteristic of Poisson law

# Energy distribution of recoil electrons

for small collision number ( $\bar{k} = 0.5$ )



# Energy distribution of beam passed through a light target

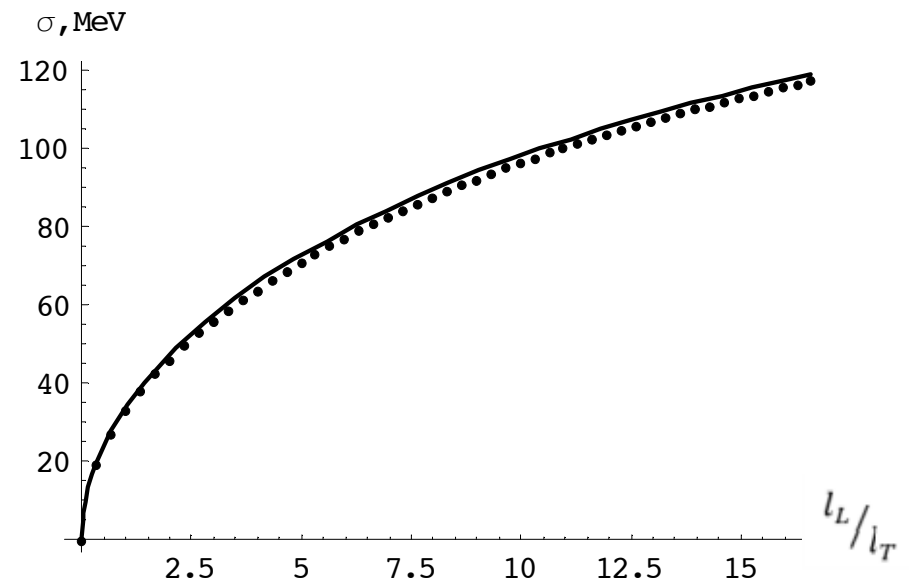
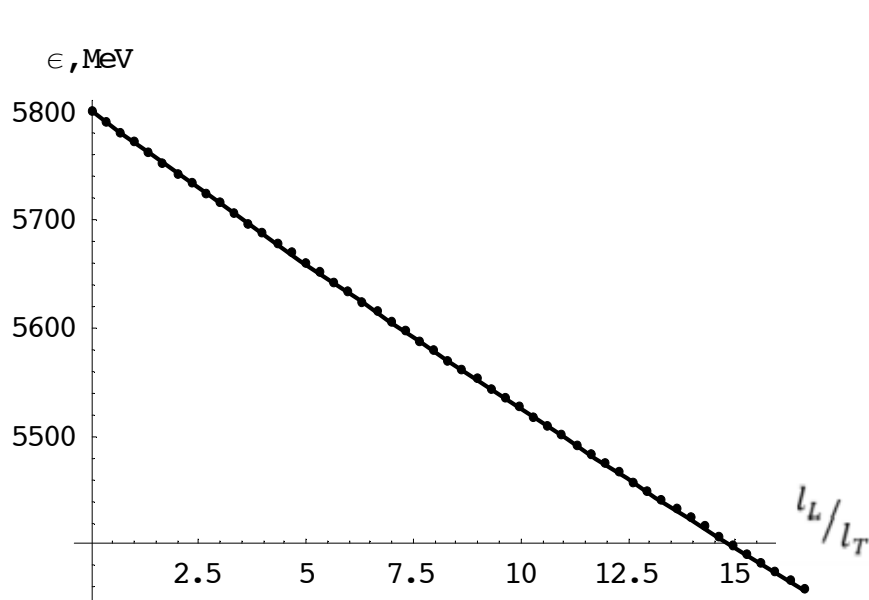
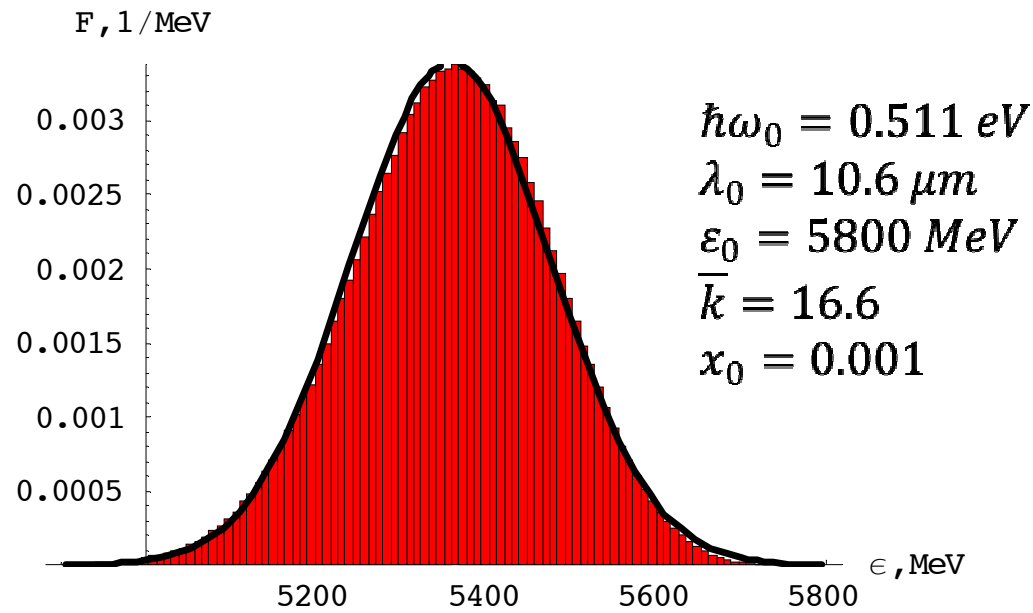


Curves – gaussian distribution with parameters

$$\bar{\varepsilon}(\varepsilon_0, l_L) \approx \frac{\varepsilon_0}{1 + \frac{1}{2} \bar{k} x_0 \left(1 - \frac{21}{10} x_0\right)}, \quad \Delta(\varepsilon_0, l_L) \approx \frac{7}{20} \frac{\bar{k} \varepsilon_0^2 x_0^2}{\left(1 + \frac{1}{2} \bar{k} x_0\right)^4}$$

Analytical solutions are valid for  $x_0 \ll 1$  (see Kolchuzhkin et al. NIMB 201 (2003) 307)

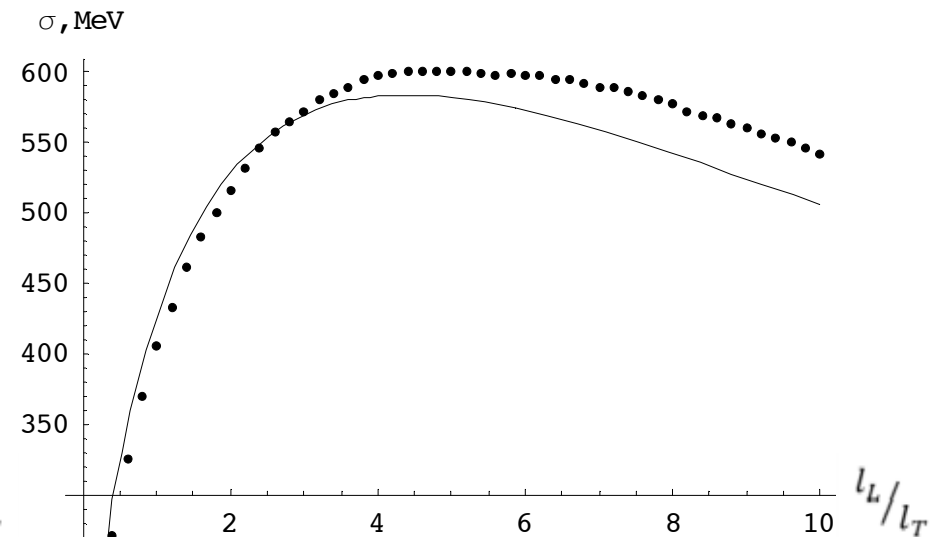
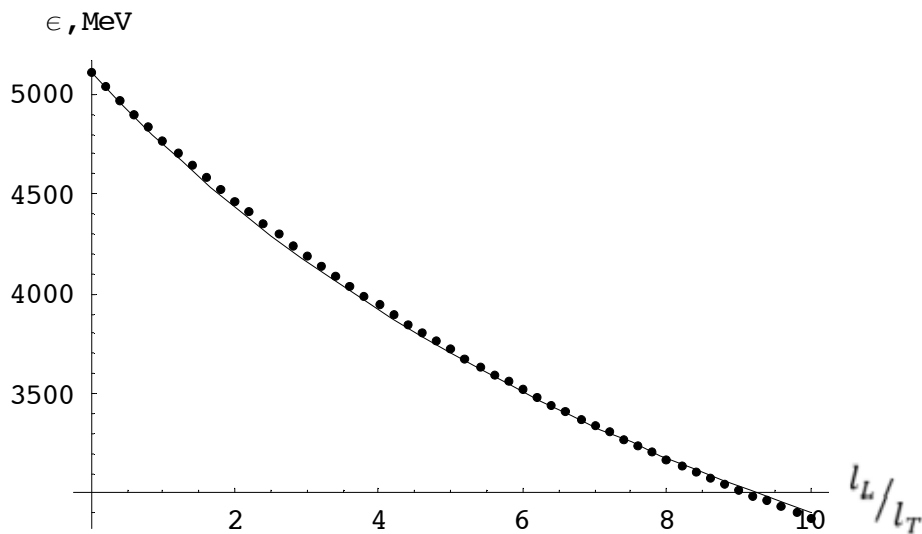
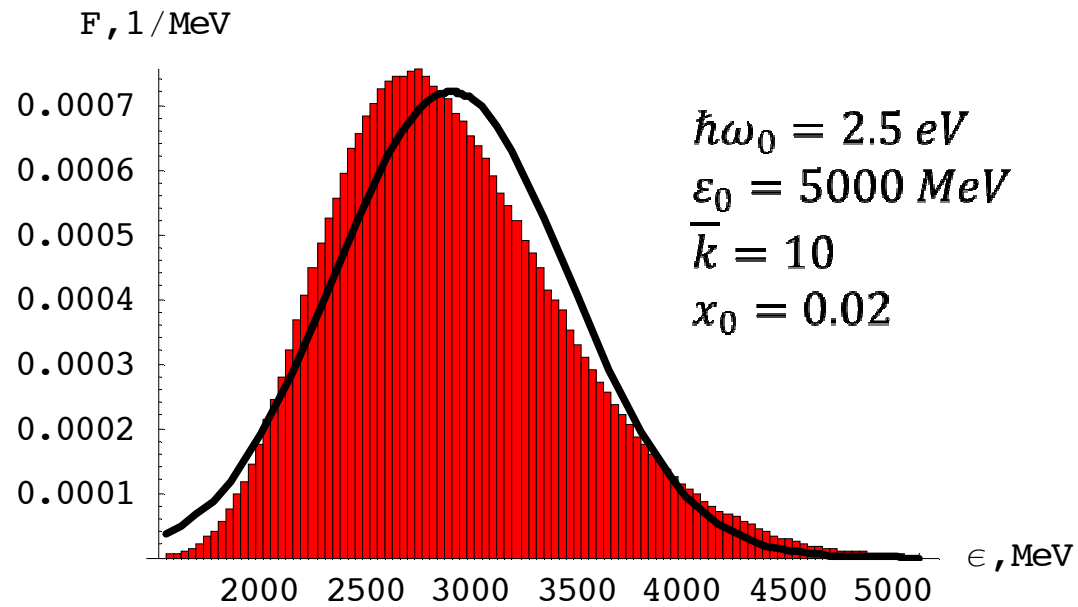
# Energy distribution of electron beam passed through a light target



Points – M-C simulation, curves – analytical dependences

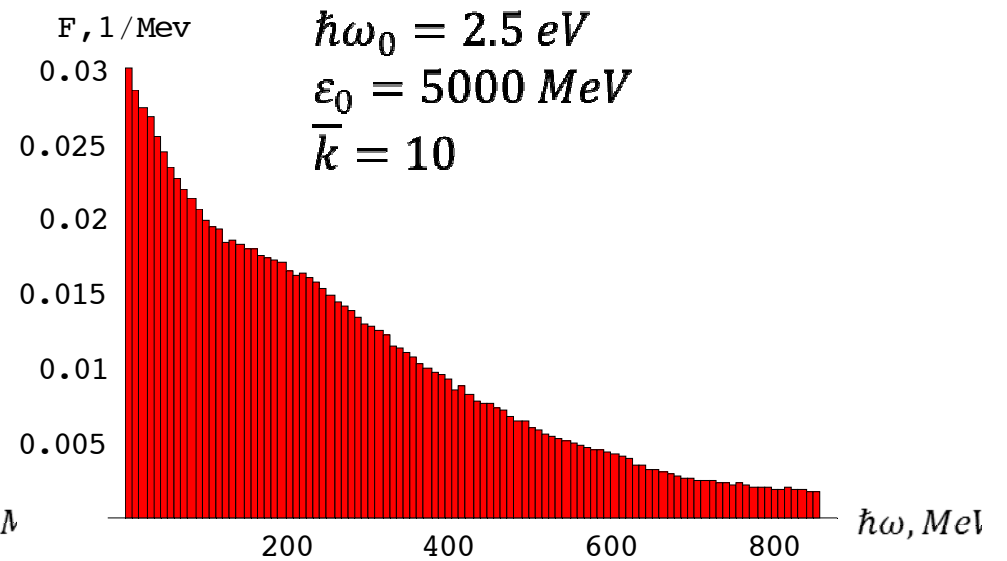
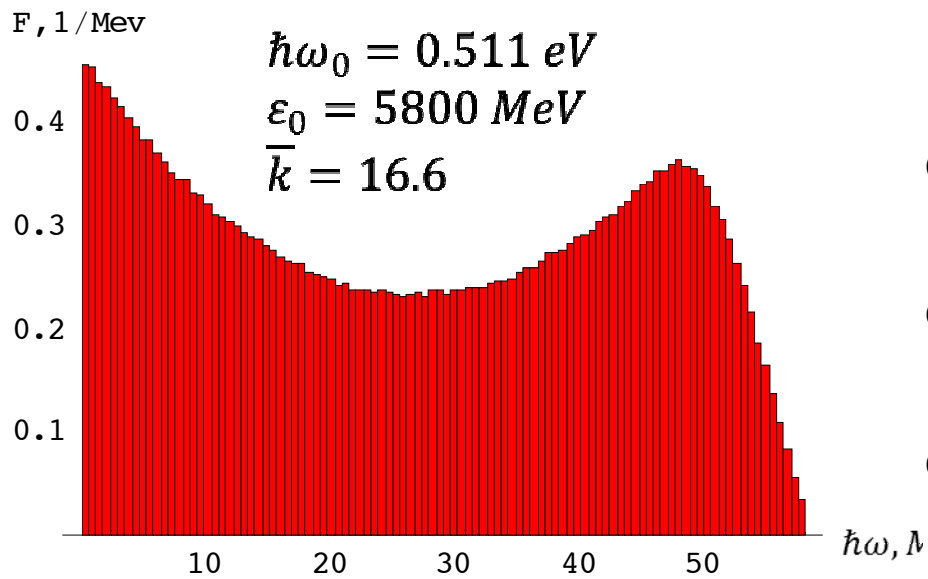


# Energy distribution of electron beam passed through a light target

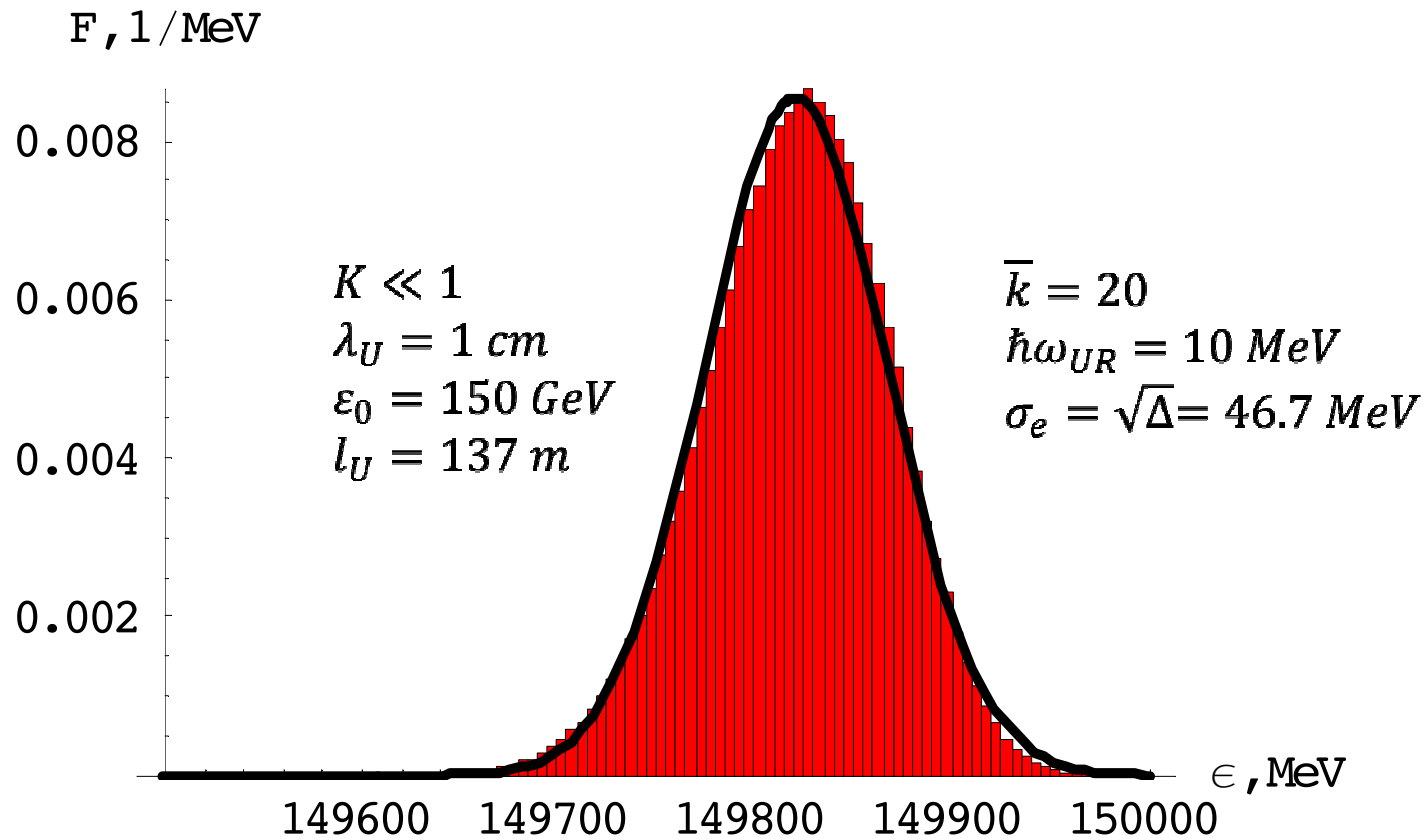


Points – M-C simulation, curves – analytical dependences

# Photon spectra as a result of MCBS process



# Energy distribution of electron beam at the undulator exit



## Spin-dependent cross section

Unpolarized  $e^+$  beam may be considered as a sum of two polarized components with a half of the initial intensity and polarized in opposite directions (indice + means parallel orientation of positron spin and momentum, + - antiparallel one)

In this case for  $P_c = +1, |\xi_z| = |\xi_{z0}| = 1$

$$\frac{d\sigma_+}{dy} = \frac{d\sigma_{++}}{dy} + \frac{d\sigma_{+-}}{dy} = 2 \left( \frac{d\sigma_0}{dy} + \frac{d\sigma_1}{dy} \right)$$

$$\frac{d\sigma_-}{dy} = \frac{d\sigma_{--}}{dy} + \frac{d\sigma_{-+}}{dy} = 2 \left( \frac{d\sigma_0}{dy} - \frac{d\sigma_1}{dy} \right)$$

where

$$\frac{d\sigma_{++}}{dy} = \frac{d\sigma_0}{dy} + \frac{d\sigma_1}{dy} + \frac{d\sigma_2}{dy} + \frac{d\sigma_3}{dy}; \quad - \text{ non spin - flip term}$$

$$\frac{d\sigma_{+-}}{dy} = \frac{d\sigma_0}{dy} + \frac{d\sigma_1}{dy} - \frac{d\sigma_2}{dy} - \frac{d\sigma_3}{dy}; \quad - \text{ spin - flip term}$$

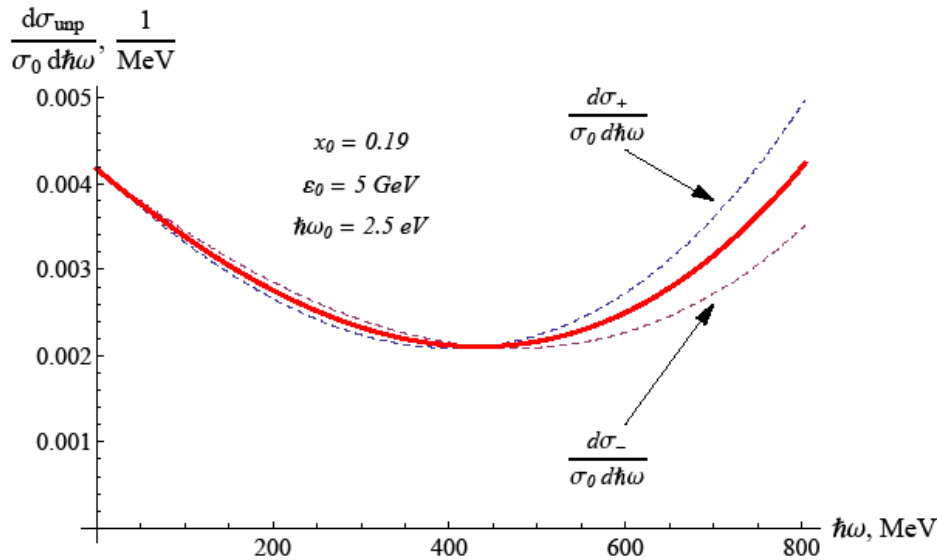
$$\frac{d\sigma_{--}}{dy} = \frac{d\sigma_0}{dy} - \frac{d\sigma_1}{dy} - \frac{d\sigma_2}{dy} + \frac{d\sigma_3}{dy}; \quad - \text{ non spin - flip term}$$

$$\frac{d\sigma_{-+}}{dy} = \frac{d\sigma_0}{dy} - \frac{d\sigma_1}{dy} + \frac{d\sigma_2}{dy} - \frac{d\sigma_3}{dy}; \quad - \text{ spin - flip term}$$

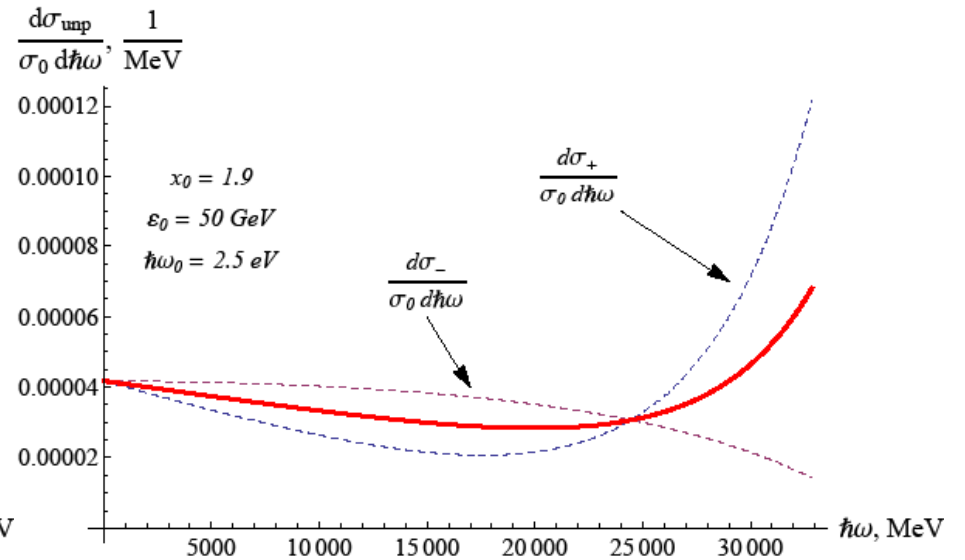
For unpolarized beam (after averaging over initial polarization states).

$$\frac{d\sigma_{unp}}{dy} = 2 \frac{d\sigma_0}{dy} \approx \frac{\pi r_0^2}{x_0} \left\{ \frac{1}{1-y} + 1 - y - s^2 \right\}$$

$$\hbar\omega_{\max} = \gamma_0 mc^2 \frac{x_0}{1+x_0}$$

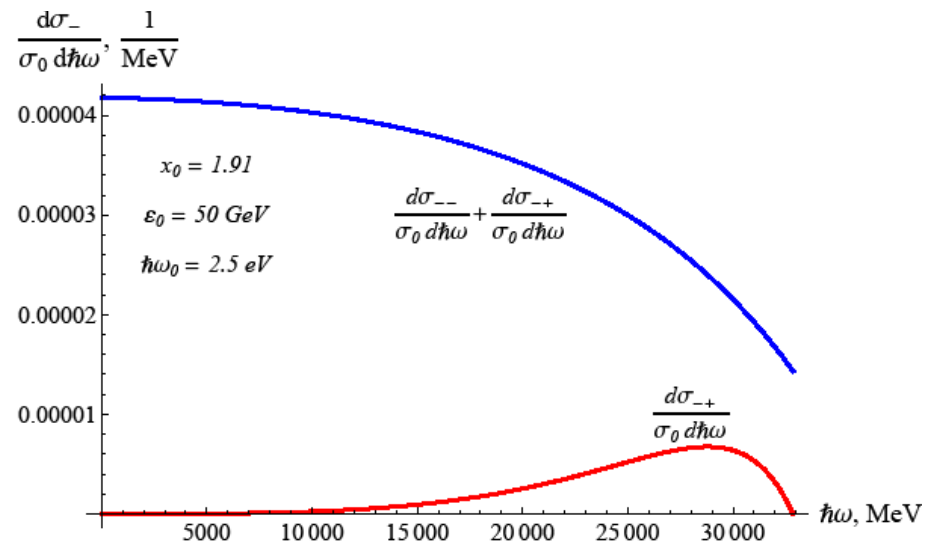
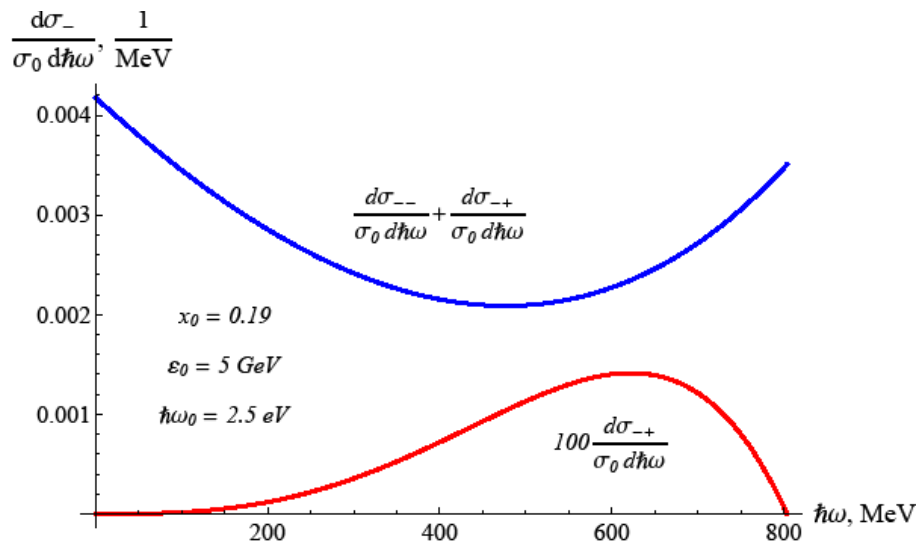
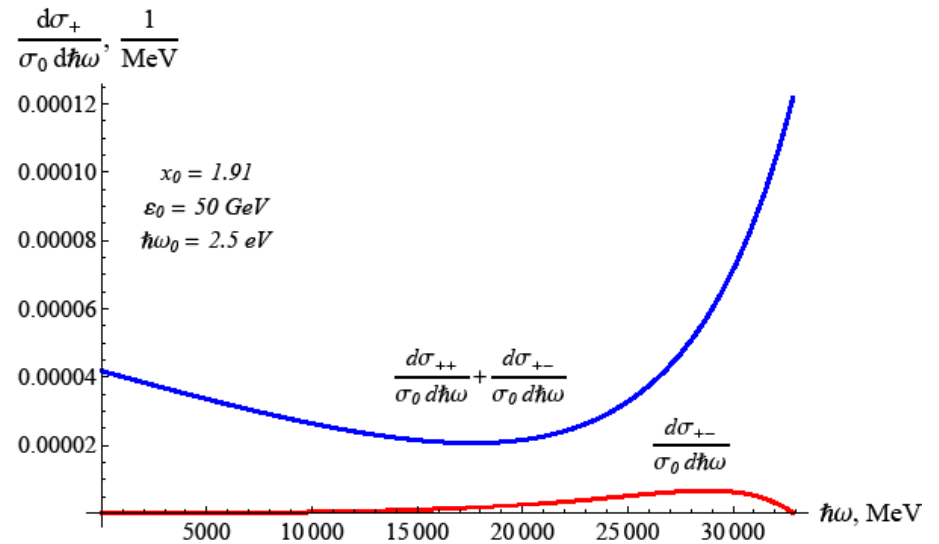
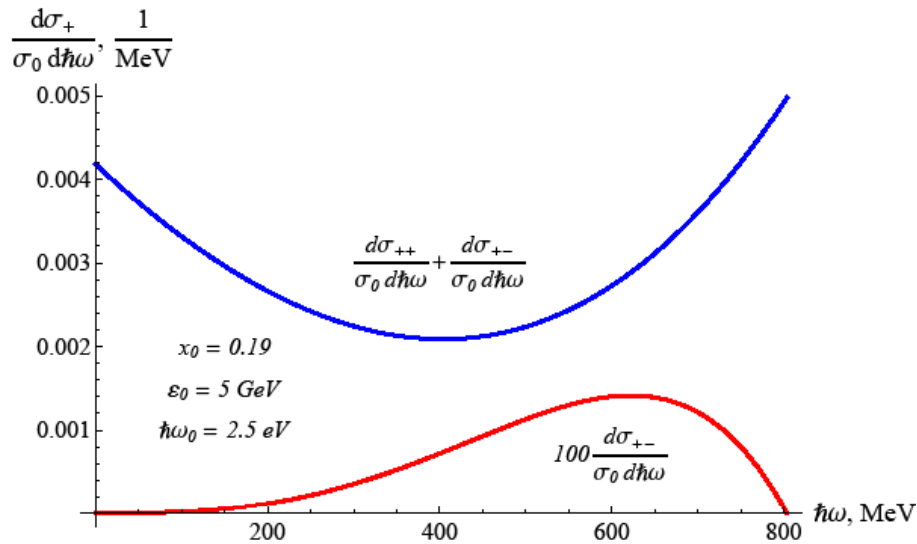


$$\hbar\omega_{\max} = 803.546 \text{ MeV}$$



$$\hbar\omega_{\max} = 32846.3 \text{ MeV}$$

# Comparison of both parts of cross-section for different electron energies



It is evidently for any electron energy

$$\frac{d\sigma_{+-}}{dy} = \frac{d\sigma_{-+}}{dy}$$

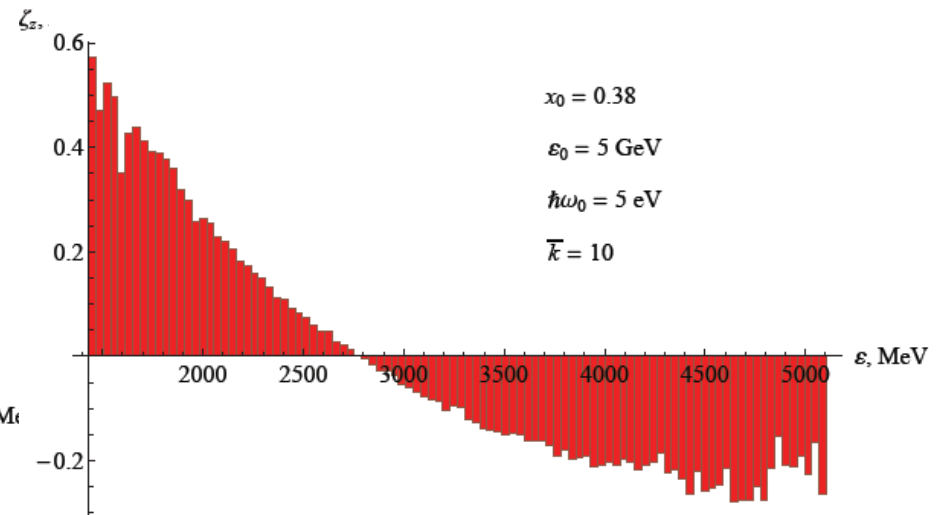
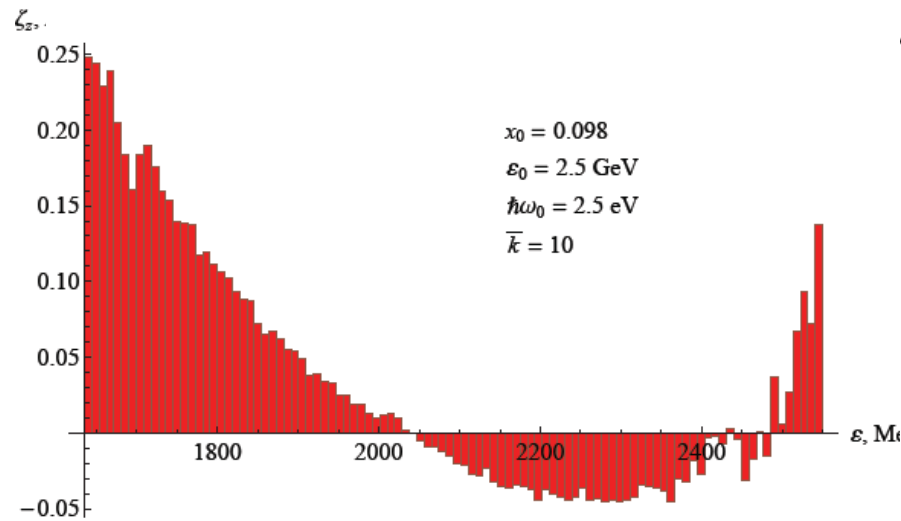
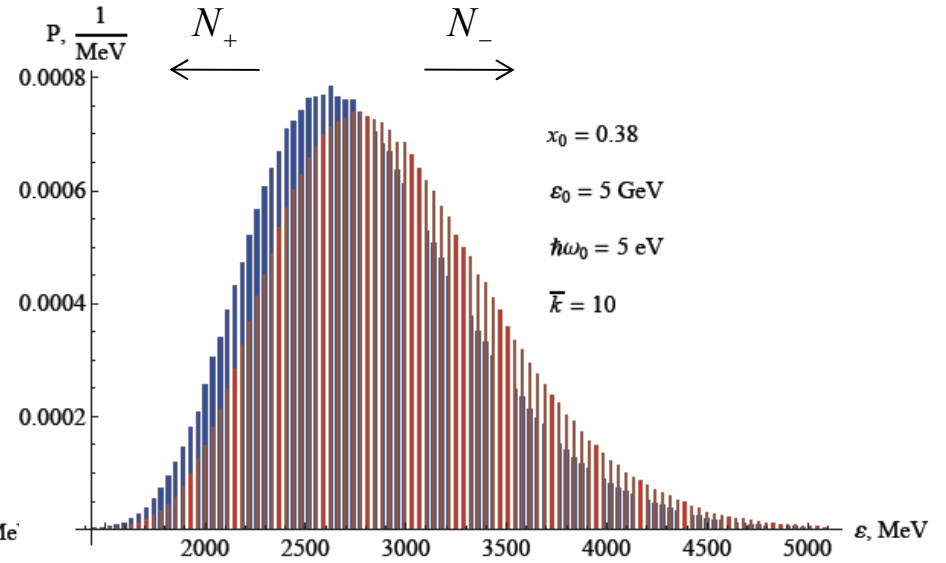
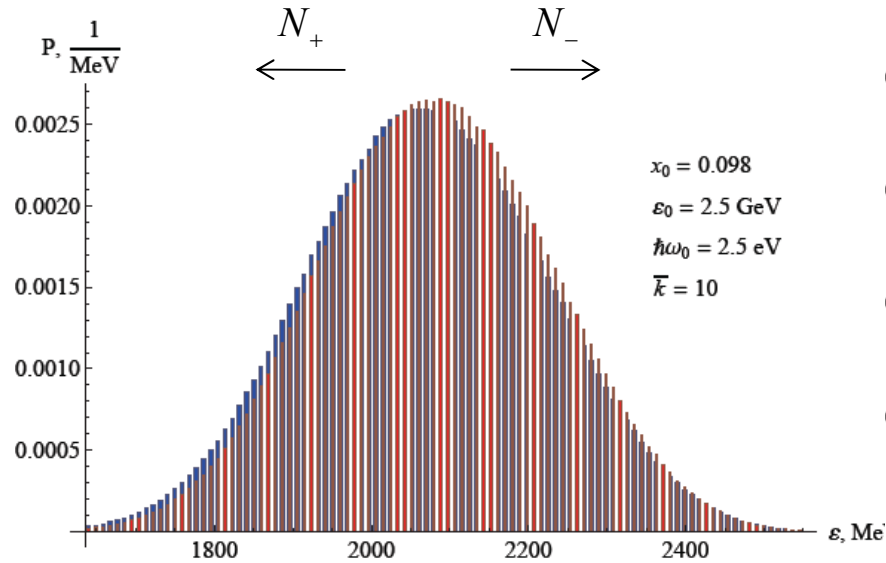
within an accuracy  $\gamma_0^{-1}$ .

It means there is no polarisation of the final beam as whole.

But for the case when each positron in a beam will interact with *CP* laser photons a few times (multiple Compton backscattering process) the final positron beam will have the non - zeroth polarization for a part of beam due to difference in cross - sections :

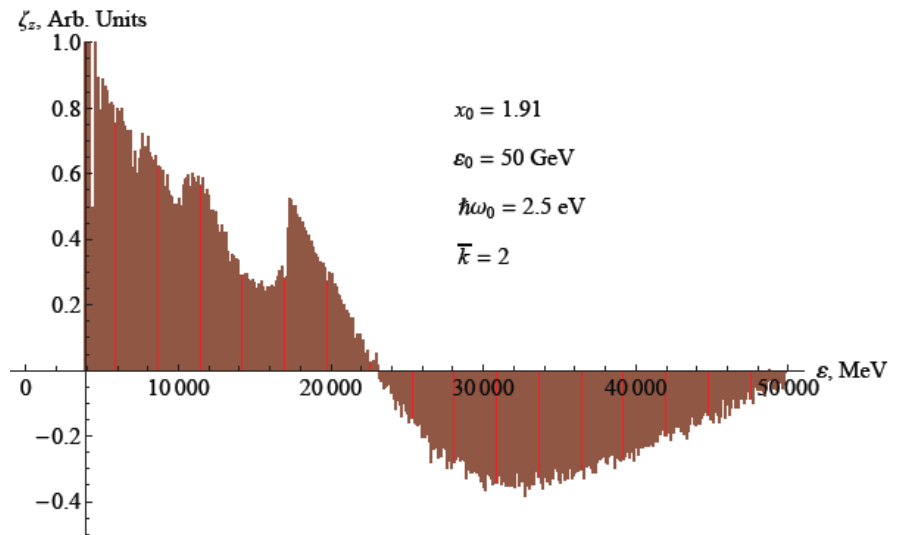
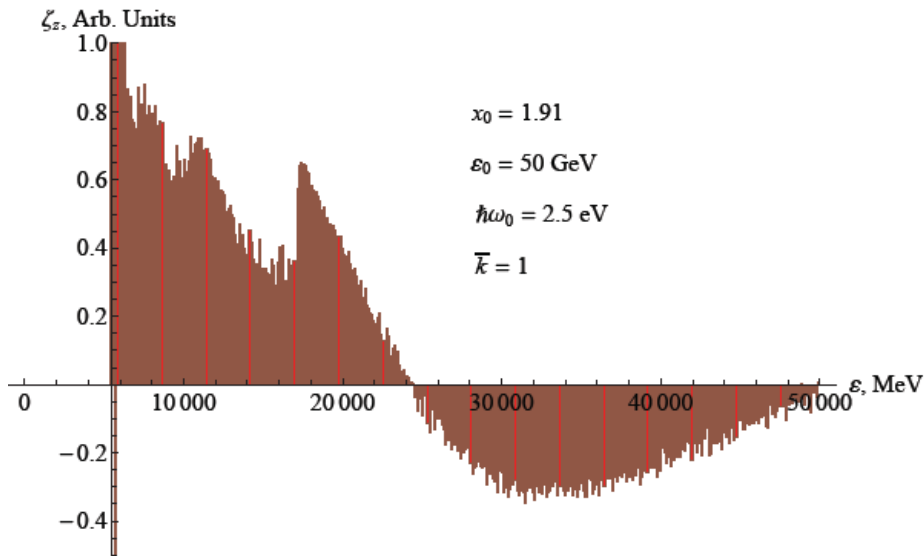
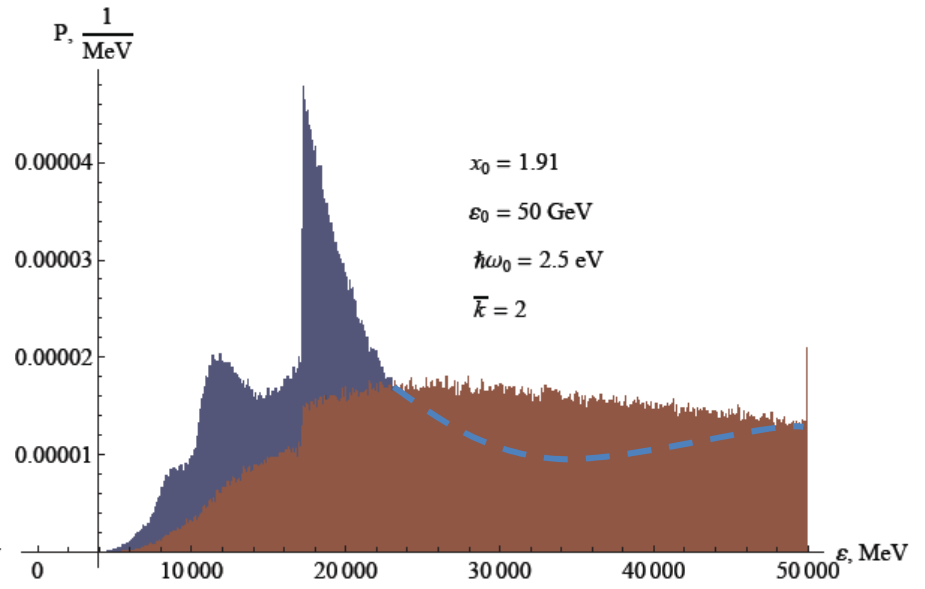
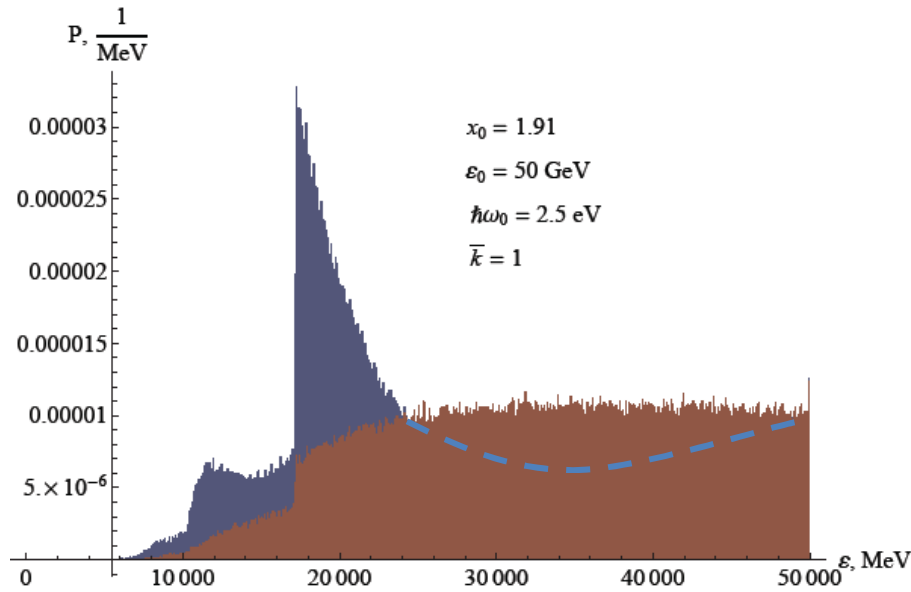
$$\frac{d\sigma_{+}}{dy} \neq \frac{d\sigma_{-}}{dy}$$

# Polarization of a final beam





# Initial electron energy 50 GeV



## Summary

- Distribution over number of emitted photons describes by Poisson law with a good accuracy
- In the MCBS process (and for ordinary UR also but not for FEL) the final distribution of electrons is continuous, which may be described by gaussian one.

Thanks for your attention!

- Even for small mean number of collisions ( $\langle k \rangle \sim 1$ ) there is significant contribution of events with  $k = 2, 3, \dots$  photons from each electron/positron
- The ordinary multiple Compton - backscattering process (plane - wave approximation) may provide polarization of a part of unpolarized beam
- For the case  $x_0 \geq 0.1$  a resulting photon spectrum is distorted significantly if  $\bar{k}_{MCBS} \gg 1$  in comparison with a single - photon spectrum